# MOSFET N-Channel POWERTRENCH<sup>®</sup>

## 40 V, 300 A, 0.85 m $\Omega$

## **General Description**

This N-Channel MV MOSFET is produced using ON Semiconductor's advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

## Features

- Max  $R_{DS(on)} = 0.85 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 47 \text{ A}$
- Max  $R_{DS(on)}$  = 1.2 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 38 A
- Advanced Package and Silicon combination for Low r<sub>DS(on)</sub> and High Efficiency
- MSL1 Robust Package Design
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

## Applications

- Primary DC–DC MOSFET
- Secondary Synchronous Rectifier
- Load Switch

## MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain to Source Voltage	40	V
V <sub>GS</sub>	Gate to Source Voltage	±20	V
I <sub>D</sub>	Drain Current: Continuous ( $T_c = 25^{\circ}C$ ) (Note 5) Continuous $T_c = 100^{\circ}C$ (Note 5)	300	A
	Continuous, $T_A = 25^{\circ}C$ (Note 1a) Pulsed (Note 4)	212	
		49	
		1464	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)	1176	mJ
PD	Power Dissipation:		W
	$T_{C} = 25^{\circ}C$	125	
	T <sub>A</sub> = 25°C (Note 1a)	3.33	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 to +175	°C

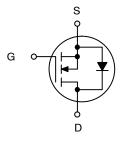
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



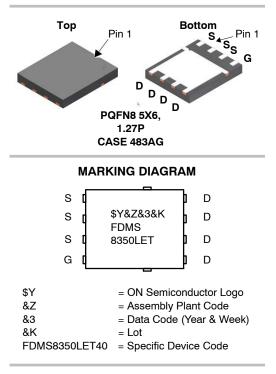
## **ON Semiconductor®**

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V <sub>DS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	0.85 mΩ @ 10 V	47 A
	1.2 mΩ @ 4.5 V	



N-CHANNEL MOSFET



## **ORDERING INFORMATION**

See detailed ordering and shipping information on page 3 of this data sheet.

Semiconductor Components Industries, LLC, 2017 June, 2019 – Rev. 2

## THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ ext{ heta}JC}$	JC Thermal Resistance, Junction to Case		°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	45	

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	40			V
$\Delta BV_{DSS}$ / $\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , referenced to $25^{\circ}\text{C}$		17		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ = 32 V, $V_{GS}$ = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20$ V, $V_{DS} = 0$ V			±100	nA
ON CHARA	CTERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$	1.0	1.8	3.0	V
${\Delta V_{GS(th)} \over /\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu A$ , referenced to $25^{\circ}C$		-6		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS}$ = 10 V, I <sub>D</sub> = 47 A		0.68	0.85	mΩ
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 38 \text{ A}$		0.96	1.2	
		$V_{GS}$ = 10 V, $I_D$ = 47 A, $T_J$ = 150°C		1.1	1.4	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 47 A		247		S
DYNAMIC C	HARACTERISTICS				-	
C <sub>iss</sub>	Input Capacitance	$V_{DS}$ = 20 V, $V_{GS}$ = 0 V, f = 1 MHz		11850	16590	pF
C <sub>oss</sub>	Output Capacitance			3430	4805	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			69	100	pF
Rg	Gate Resistance		0.1	1.2	2.4	Ω
SWITCHING	CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 20 \text{ V}, \text{ I}_{D} = 47 \text{ A}, \text{ V}_{GS} = 10 \text{ V},$		32	51	ns
t <sub>r</sub>	Rise Time	$R_{GEN} = 6 \Omega$		19	34	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			74	118	ns
t <sub>f</sub>	Fall Time	7		15	27	ns
Qg	Total Gate Charge	$V_{GS} = 0 V$ to 10 V		156	219	nC
		$V_{GS} = 0 V$ to 4.5 V		73	102	nC
Q <sub>gs</sub>	Gate to Source Charge	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 47 A		33		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 47 A		16		nC

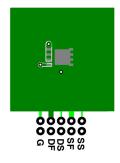
## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.1 A (Note 2)		0.7	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 47 A (Note 2)		0.8	1.3	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 47 A, di/dt = 100 A/μs		81	129	ns
Q <sub>rr</sub>	Reverse Recovery Charge	]		82	131	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.

## NOTES:



a) 45°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 115°C/W when mounted on a minimum pad of 2 oz copper.

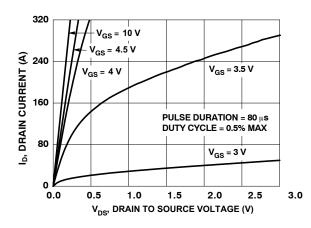
- 2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 1176 mJ is based on starting  $T_J = 25^{\circ}$ C; L = 3 mH,  $I_{AS} = 28$  A,  $V_{DD} = 40$  V,  $V_{GS} = 10$  V. 100% test at L = 0.1 mH,  $I_{AS} = 87$  A. 4. Pulsed ld please refer to Fig 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

### **ORDERING INFORMATION**

Device	Marking	Package	Reel Size	Tape Width	Quantity
FDMS8350LET40	FDMS8350LET	Power 56	13″	12 mm	3000 units

## **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25°C unless otherwise noted)





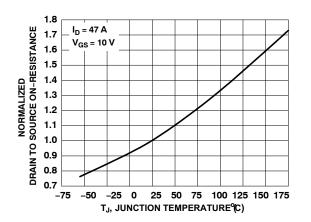
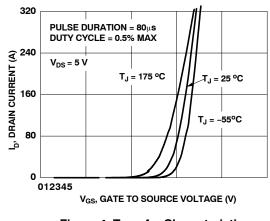
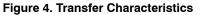


Figure 2. Normalized On–Resistance vs Junction Temperature





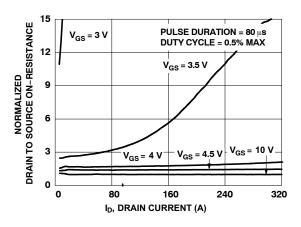


Figure 6. Normalized On–Resistance vs Drain Current and Gate Voltage

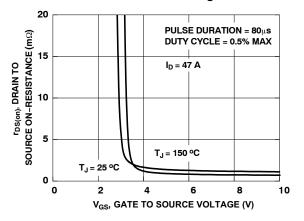


Figure 3. On–Resistance vs Gate to Source Voltage

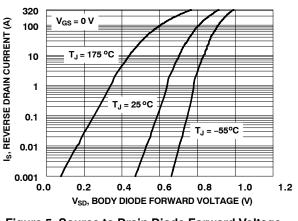


Figure 5. Source to Drain Diode Forward Voltage vs Source Current

## **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25°C unless otherwise noted)

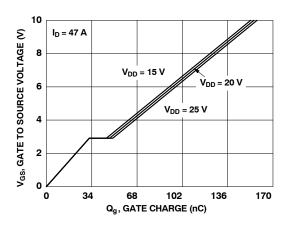


Figure 7. Gate Charge Characteristics

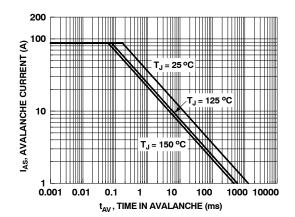


Figure 9. Unclamped Inductive Switching Capability

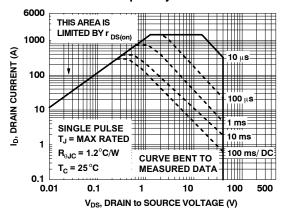


Figure 11. Forward Bias Safe Operating Area

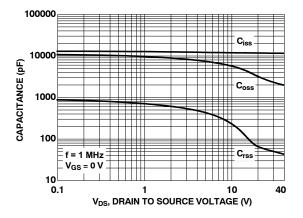


Figure 8. Capacitance vs Drain to Source Voltage

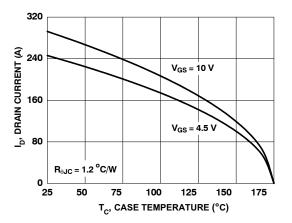
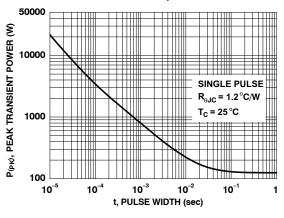


Figure 10. Maximum Continuous Drain Current vs Case Temperature





## **TYPICAL CHARACTERISTICS**

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

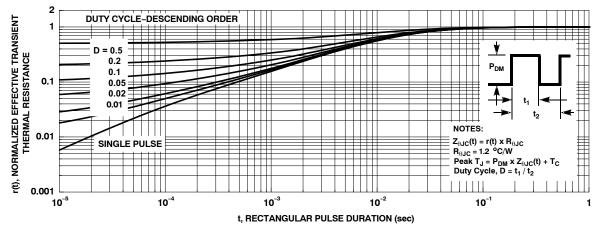
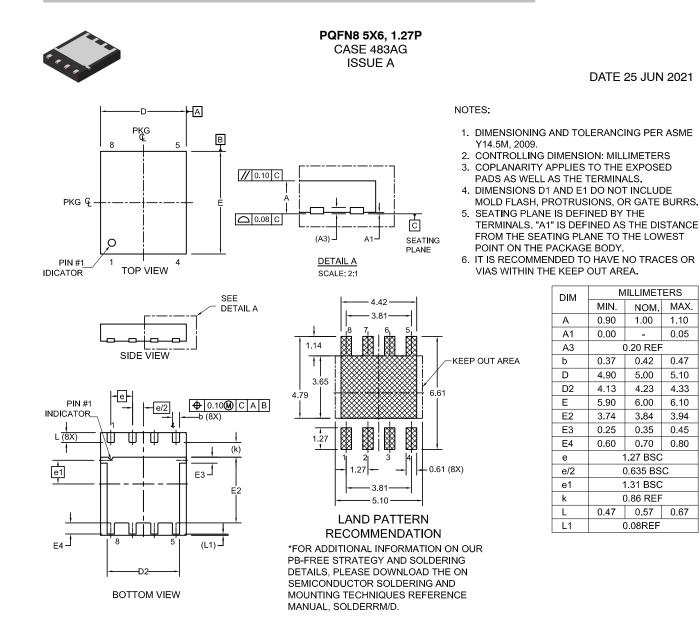


Figure 13. Junction-to-Case Transient Thermal Response Curve





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